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# R1LV0408D Series

4M SRAM (512-kword × 8-bit)

REJ03C0310-0100

Rev.1.00

May.24.2007

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## Description

The R1LV0408D is a 4-Mbit static RAM organized 512-kword × 8-bit, fabricated by Renesas's high-performance 0.15 $\mu$ m CMOS and TFT technologies. R1LV0408D Series has realized higher density, higher performance and low power consumption. The R1LV0408D Series offers low power standby power dissipation; therefore, it is suitable for battery backup systems. It has packaged in 32-pin SOP, 32-pin TSOP II and 32-pin STSOP.

## Features

- Single 3 V supply: 2.7 V to 3.6 V
- Access time: 55/70 ns (max)
- Power dissipation:
  - Standby: 3  $\mu$ W (typ)
- Equal access and cycle times
- Common data input and output.
  - Three state output
- Directly TTL compatible.
  - All inputs and outputs
- Battery backup operation.

## R1LV0408D Series

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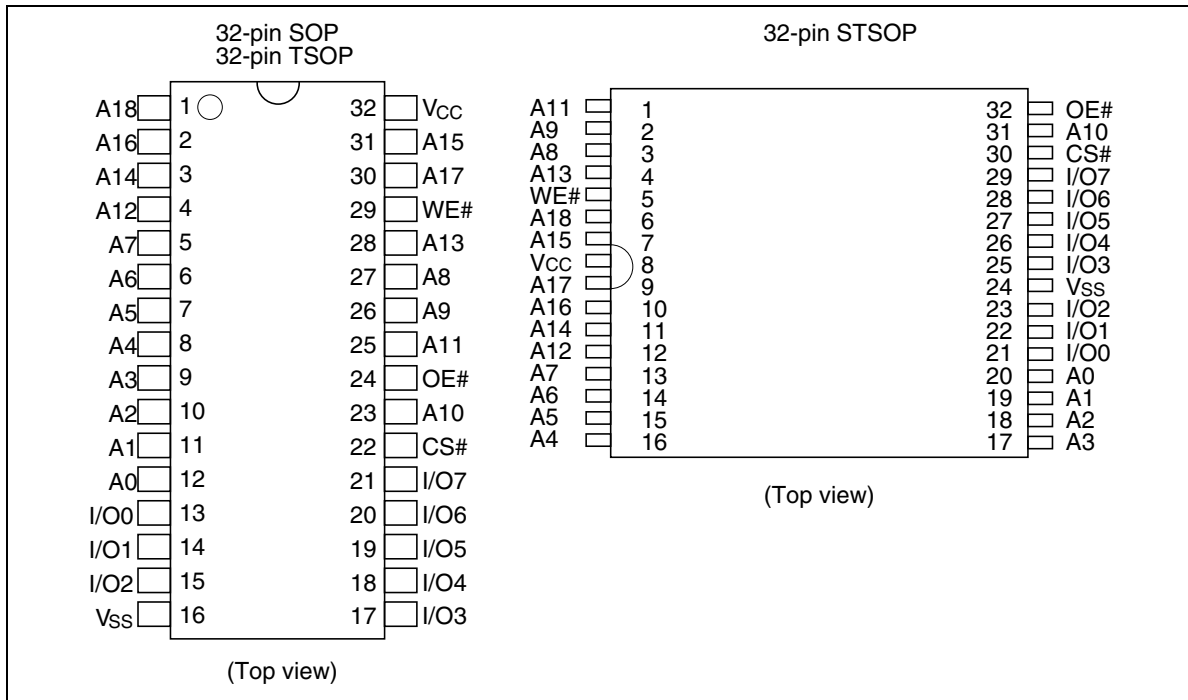
### Ordering Information

| Type No.        | Access time | Package                                  |
|-----------------|-------------|--|
| R1LV0408DSP-5S% | 55 ns       | 525-mil 32-pin plastic SOP (32P2M-A)     |
| R1LV0408DSP-7L% | 70 ns       |  |
| R1LV0408DSB-5S% | 55 ns       | 400-mil 32-pin plastic TSOP II (32P3Y-H) |
| R1LV0408DSB-7L% | 70 ns       |  |
| R1LV0408DSA-5S% | 55 ns       | 8mm × 13.4mm STSOP (32P3K-B)             |
| R1LV0408DSA-7L% | 70 ns       |  |

?: Temperature version; see table below.

| ? | Temperature Range |
|---|-------------------|
| R | 0 to +70°C        |
| I | -40 to +85°C      |

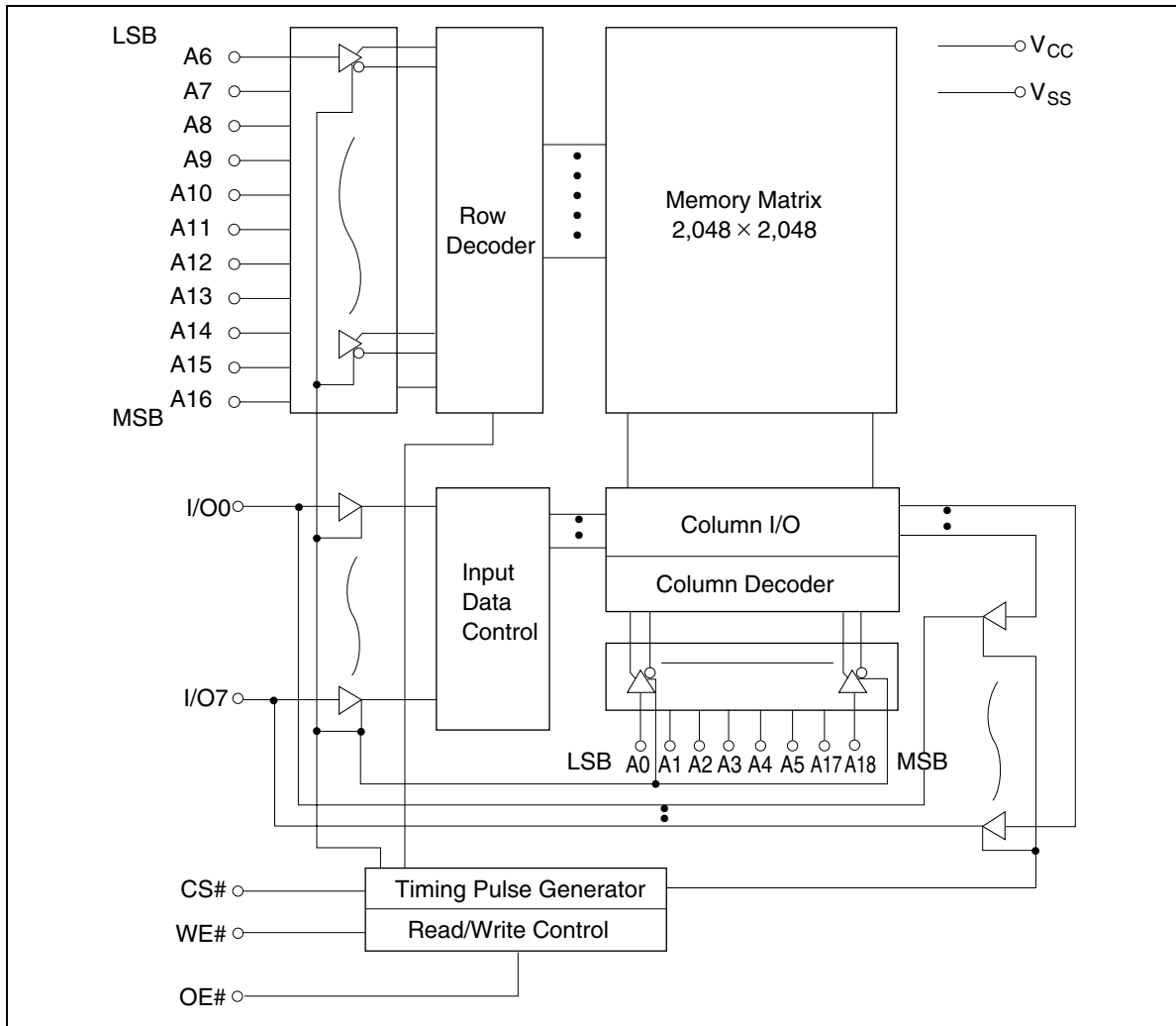
## Pin Arrangement



## Pin Description

| Pin name                | Function          |
|-------------------------|-------------------|
| A0 to A18               | Address input     |
| I/O0 to I/O7            | Data input/output |
| CS# ( $\overline{CS}$ ) | Chip select       |
| OE# ( $\overline{OE}$ ) | Output enable     |
| WE# ( $\overline{WE}$ ) | Write enable      |
| V <sub>cc</sub>         | Power supply      |
| V <sub>ss</sub>         | Ground            |

Block Diagram



## Operation Table

| WE# | CS# | OE# | Mode           | V <sub>CC</sub> current            | I/O0 to I/O7 | Ref. cycle      |
|-----|-----|-----|----------------|------------------------------------|--------------|-----------------|
| ×   | H   | ×   | Not selected   | I <sub>SB</sub> , I <sub>SB1</sub> | High-Z       | —               |
| H   | L   | H   | Output disable | I <sub>CC</sub>                    | High-Z       | —               |
| H   | L   | L   | Read           | I <sub>CC</sub>                    | Dout         | Read cycle      |
| L   | L   | H   | Write          | I <sub>CC</sub>                    | Din          | Write cycle (1) |
| L   | L   | L   | Write          | I <sub>CC</sub>                    | Din          | Write cycle (2) |

Note: H: V<sub>IH</sub>, L: V<sub>IL</sub>, ×: V<sub>IH</sub> or V<sub>IL</sub>

## Absolute Maximum Ratings

| Parameter   | Symbol          | Value   | Unit       |
|---|-----------------|---|------------|
| Power supply voltage relative to V <sub>SS</sub>        | V <sub>CC</sub> | -0.5 to +4.6  | V          |
| Terminal voltage on any pin relative to V <sub>SS</sub> | V <sub>T</sub>  | -0.5* <sup>1</sup> to V <sub>CC</sub> + 0.5* <sup>2</sup> | V          |
| Power dissipation                                       | P <sub>T</sub>  | 0.7   | W          |
| Operating temperature                                   | Topr            | R ver.  | 0 to +70   |
|   |                 | I ver.  | -40 to +85 |
| Storage temperature range                               | Tstg            | -65 to +150   | °C         |
| Storage temperature range under bias                    | Tbias           | R ver.  | 0 to +70   |
|   |                 | I ver.  | -40 to +85 |

Notes: 1. V<sub>T</sub> min: -3.0 V for pulse half-width ≤ 30 ns.

2. Maximum voltage is +4.6 V.

## DC Operating Conditions

| Parameter                 | Symbol          | Min                | Typ | Max                   | Unit |
|---------------------------|-----------------|--------------------|-----|-----------------------|------|
| Supply voltage            | V <sub>CC</sub> | 2.7                | 3.0 | 3.6                   | V    |
|                           | V <sub>SS</sub> | 0                  | 0   | 0                     | V    |
| Input high voltage        | V <sub>IH</sub> | 2.2                | —   | V <sub>CC</sub> + 0.3 | V    |
| Input low voltage         | V <sub>IL</sub> | -0.3* <sup>1</sup> | —   | 0.6                   | V    |
| Ambient temperature range | R ver.          | Ta                 | 0   | +70                   | °C   |
|                           | I ver.          |                    | -40 | +85                   |      |

Note: 1. V<sub>IL</sub> min: -3.0 V for pulse half-width ≤ 30 ns.

## DC Characteristics

| Parameter                 |      | Symbol     | Min            | Typ   | Max | Unit          | Test conditions  |  |
|---------------------------|------|------------|----------------|-------|-----|---------------|--|--|
| Input leakage current     |      | $ I_{LI} $ | —              | —     | 1   | $\mu\text{A}$ | $V_{in} = V_{SS}$ to $V_{CC}$  |  |
| Output leakage current    |      | $ I_{LO} $ | —              | —     | 1   | $\mu\text{A}$ | CS# = $V_{IH}$ or OE# = $V_{IH}$ or WE# = $V_{IL}$ or $V_{IO} = V_{SS}$ to $V_{CC}$  |  |
| Operating current         |      | $I_{CC}$   | —              | —     | 10  | mA            | CS# = $V_{IL}$ , Others = $V_{IH}/V_{IL}$ , $I_{IO} = 0$ mA  |  |
| Average operating current |      | $I_{CC1}$  | —              | —     | 25  | mA            | Min. cycle, duty = 100%, CS# = $V_{IL}$ , Others = $V_{IH}/V_{IL}$ , $I_{IO} = 0$ mA   |  |
|                           |      | $I_{CC2}$  | —              | —     | 5   | mA            | Cycle time = 1 $\mu\text{s}$ , duty = 100%, $I_{IO} = 0$ mA, CS# $\leq 0.2$ V, $V_{IH} \geq V_{CC} - 0.2$ V, $V_{IL} \leq 0.2$ V |  |
| Standby current           |      | $I_{SB}$   | —              | 0.1*1 | 0.3 | mA            | CS# = $V_{IH}$   |  |
| Standby current           | -5S% | to +85°C   | $I_{SB1}$      | —     | —   | 10            | $\mu\text{A}$  | Average values<br>$V_{in} \geq 0$ V, CS# $\geq V_{CC} - 0.2$ V |
|                           |      | to +70°C   | $I_{SB1}$      | —     | —   | 8             | $\mu\text{A}$  |  |
|                           |      | to +40°C   | $I_{SB1}$      | —     | —   | 3             | $\mu\text{A}$  |  |
|                           |      | to +25°C   | $I_{SB1}$      | —     | 1*1 | 2.5           | $\mu\text{A}$  |  |
|                           | -7L% | to +85°C   | $I_{SB1}$      | —     | —   | 20            | $\mu\text{A}$  |  |
|                           |      | to +70°C   | $I_{SB1}$      | —     | —   | 16            | $\mu\text{A}$  |  |
|                           |      | to +40°C   | $I_{SB1}$      | —     | —   | 10            | $\mu\text{A}$  |  |
|                           |      | to +25°C   | $I_{SB1}$      | —     | 1*1 | 10            | $\mu\text{A}$  |  |
| Output low voltage        |      | $V_{OL}$   | —              | —     | 0.4 | V             | $I_{OL} = 2.1$ mA  |  |
|                           |      | $V_{OL2}$  | —              | —     | 0.2 | V             | $I_{OL} = 100$ $\mu\text{A}$   |  |
| Output high voltage       |      | $V_{OH}$   | 2.4            | —     | —   | V             | $I_{OH} = -1.0$ mA   |  |
|                           |      | $V_{OH2}$  | $V_{CC} - 0.2$ | —     | —   | —             | V  | $I_{OH} = -0.1$ mA   |

Note: 1. Typical values are at  $V_{CC} = 3.0$  V,  $T_a = +25^\circ\text{C}$  and specified loading, and not guaranteed.

## Capacitance

( $T_a = +25^\circ\text{C}$ ,  $f = 1.0$  MHz)

| Parameter                | Symbol   | Min | Typ | Max | Unit | Test conditions | Note |
|--------------------------|----------|-----|-----|-----|------|-----------------|------|
| Input capacitance        | $C_{in}$ | —   | —   | 8   | pF   | $V_{in} = 0$ V  | 1    |
| Input/output capacitance | $C_{IO}$ | —   | —   | 10  | pF   | $V_{IO} = 0$ V  | 1    |

Note: 1. This parameter is sampled and not 100% tested.

## AC Characteristics

( $T_a = 0$  to  $+70^\circ\text{C}$  /  $-40$  to  $+85^\circ\text{C}$ ,  $V_{CC} = 2.7$  V to  $3.6$  V)

### Test Conditions

- Input pulse levels:  $V_{IL} = 0.4$  V,  $V_{IH} = 2.4$  V
- Input rise and fall time: 5 ns
- Input and output timing reference levels: 1.5 V
- Output load: 1 TTL Gate +  $C_L$  (50 pF) (R1LV0408D-5S%)  
1 TTL Gate +  $C_L$  (100 pF) (R1LV0408D-7L%)  
(Including scope and jig)

Note: Temperature range depends on R/I-version. Please see table on page 2.

### Read Cycle

| Parameter                          | Symbol    | R1LV0408D |     |      |     | Unit | Notes |
|------------------------------------|-----------|-----------|-----|------|-----|------|-------|
|                                    |           | -5S%      |     | -7L% |     |      |       |
|                                    |           | Min       | Max | Min  | Max |      |       |
| Read cycle time                    | $t_{RC}$  | 55        | —   | 70   | —   | ns   |       |
| Address access time                | $t_{AA}$  | —         | 55  | —    | 70  | ns   |       |
| Chip select access time            | $t_{CO}$  | —         | 55  | —    | 70  | ns   |       |
| Output enable to output valid      | $t_{OE}$  | —         | 30  | —    | 35  | ns   |       |
| Chip select to output in low-Z     | $t_{LZ}$  | 10        | —   | 10   | —   | ns   | 2     |
| Output enable to output in low-Z   | $t_{OLZ}$ | 5         | —   | 5    | —   | ns   | 2     |
| Chip deselect to output in high-Z  | $t_{HZ}$  | 0         | 20  | 0    | 25  | ns   | 1, 2  |
| Output disable to output in high-Z | $t_{OHZ}$ | 0         | 20  | 0    | 25  | ns   | 1, 2  |
| Output hold from address change    | $t_{OH}$  | 10        | —   | 10   | —   | ns   |       |

## R1LV0408D Series

### Write Cycle

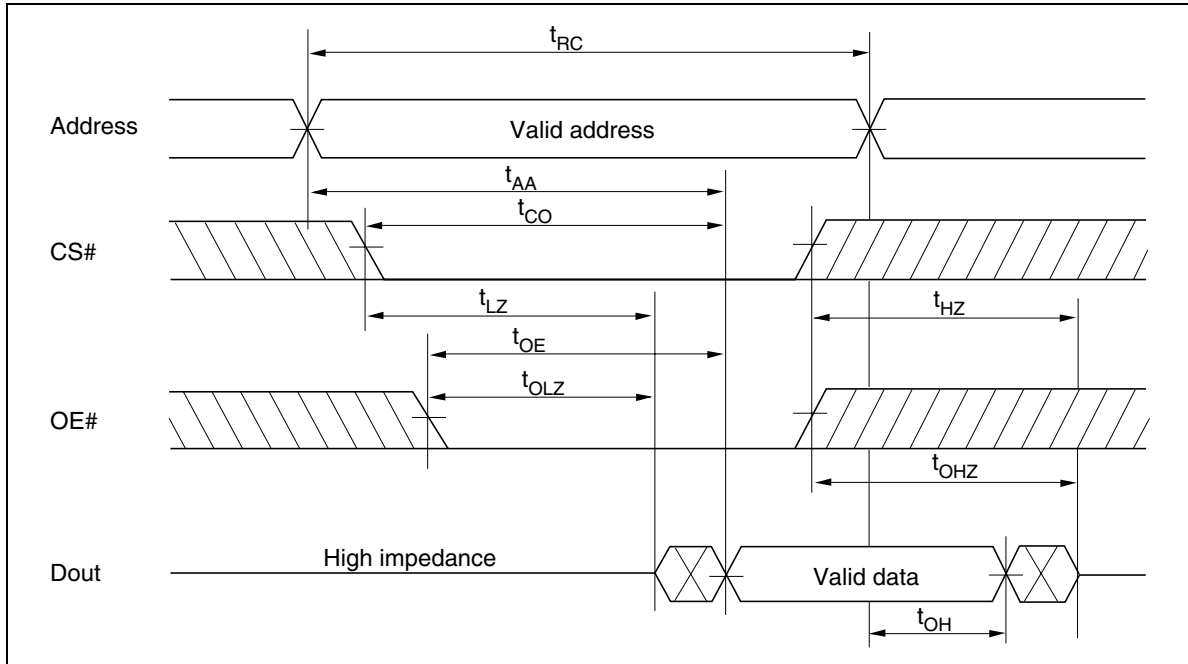
| Parameter                          | Symbol    | R1LV0408D |     |      |     | Unit | Notes   |
|------------------------------------|-----------|-----------|-----|------|-----|------|---------|
|                                    |           | -5S%      |     | -7L% |     |      |         |
|                                    |           | Min       | Max | Min  | Max |      |         |
| Write cycle time                   | $t_{WC}$  | 55        | —   | 70   | —   | ns   |         |
| Chip selection to end of write     | $t_{CW}$  | 50        | —   | 60   | —   | ns   | 4       |
| Address setup time                 | $t_{AS}$  | 0         | —   | 0    | —   | ns   | 5       |
| Address valid to end of write      | $t_{AW}$  | 50        | —   | 60   | —   | ns   |         |
| Write pulse width                  | $t_{WP}$  | 40        | —   | 50   | —   | ns   | 3, 12   |
| Write recovery time                | $t_{WR}$  | 0         | —   | 0    | —   | ns   | 6       |
| Write to output in high-Z          | $t_{WHZ}$ | 0         | 20  | 0    | 25  | ns   | 1, 2, 7 |
| Data to write time overlap         | $t_{DW}$  | 25        | —   | 30   | —   | ns   |         |
| Data hold from write time          | $t_{DH}$  | 0         | —   | 0    | —   | ns   |         |
| Output active from end of write    | $t_{OW}$  | 5         | —   | 5    | —   | ns   | 2       |
| Output disable to output in high-Z | $t_{OHZ}$ | 0         | 20  | 0    | 25  | ns   | 1, 2, 7 |

- Notes:
- $t_{HZ}$ ,  $t_{OHZ}$  and  $t_{WHZ}$  are defined as the time at which the outputs achieve the open circuit conditions and are not referred to output voltage levels.
  - This parameter is sampled and not 100% tested.
  - A write occurs during the overlap ( $t_{WP}$ ) of a low CS# and a low WE#. A write begins at the later transition of CS# going low or WE# going low. A write ends at the earlier transition of CS# going high or WE# going high.  $t_{WP}$  is measured from the beginning of write to the end of write.
  - $t_{CW}$  is measured from CS# going low to the end of write.
  - $t_{AS}$  is measured from the address valid to the beginning of write.
  - $t_{WR}$  is measured from the earlier of WE# or CS# going high to the end of write cycle.
  - During this period, I/O pins are in the output state so that the input signals of the opposite phase to the outputs must not be applied.
  - If the CS# low transition occurs simultaneously with the WE# low transition or after the WE# transition, the output remain in a high impedance state.
  - Dout is the same phase of the write data of this write cycle.
  - Dout is the read data of next address.
  - If CS# is low during this period, I/O pins are in the output state. Therefore, the input signals of the opposite phase to the outputs must not be applied to them.
  - In the write cycle with OE# low fixed,  $t_{WP}$  must satisfy the following equation to avoid a problem of data bus contention.  $t_{WP} \geq t_{DW} \text{ min} + t_{WHZ} \text{ max}$

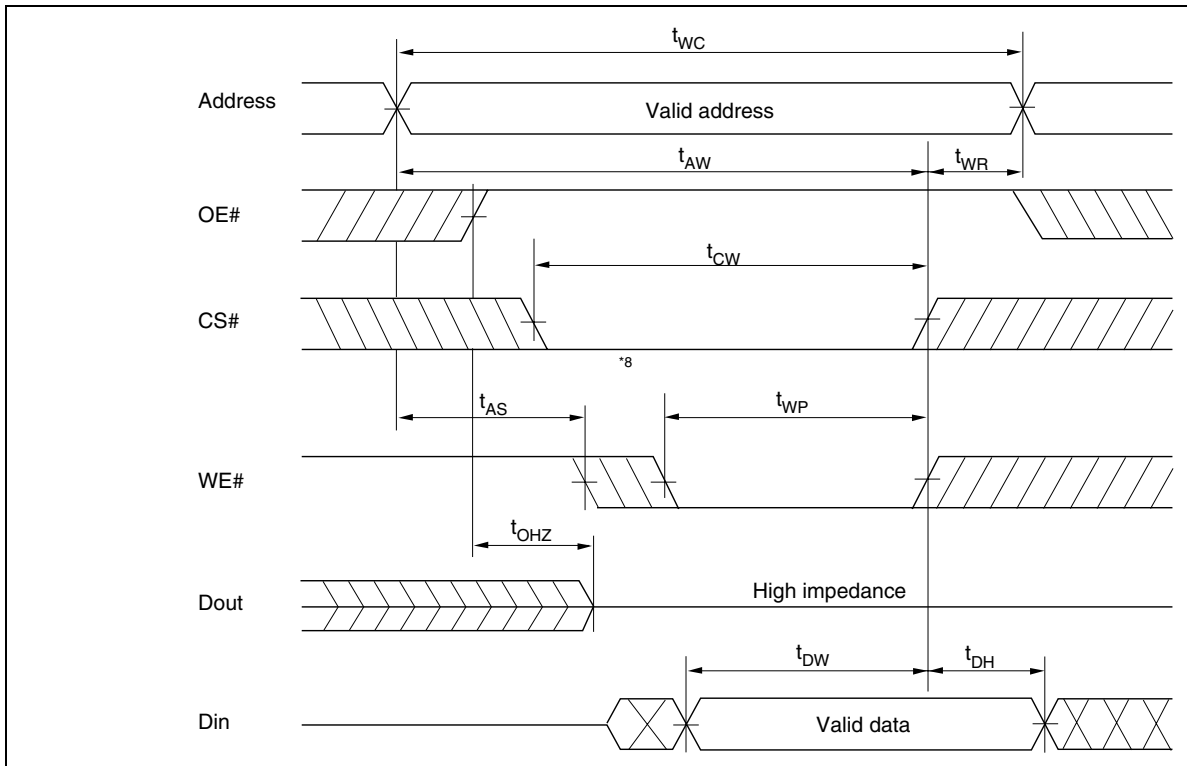


## Timing Waveform

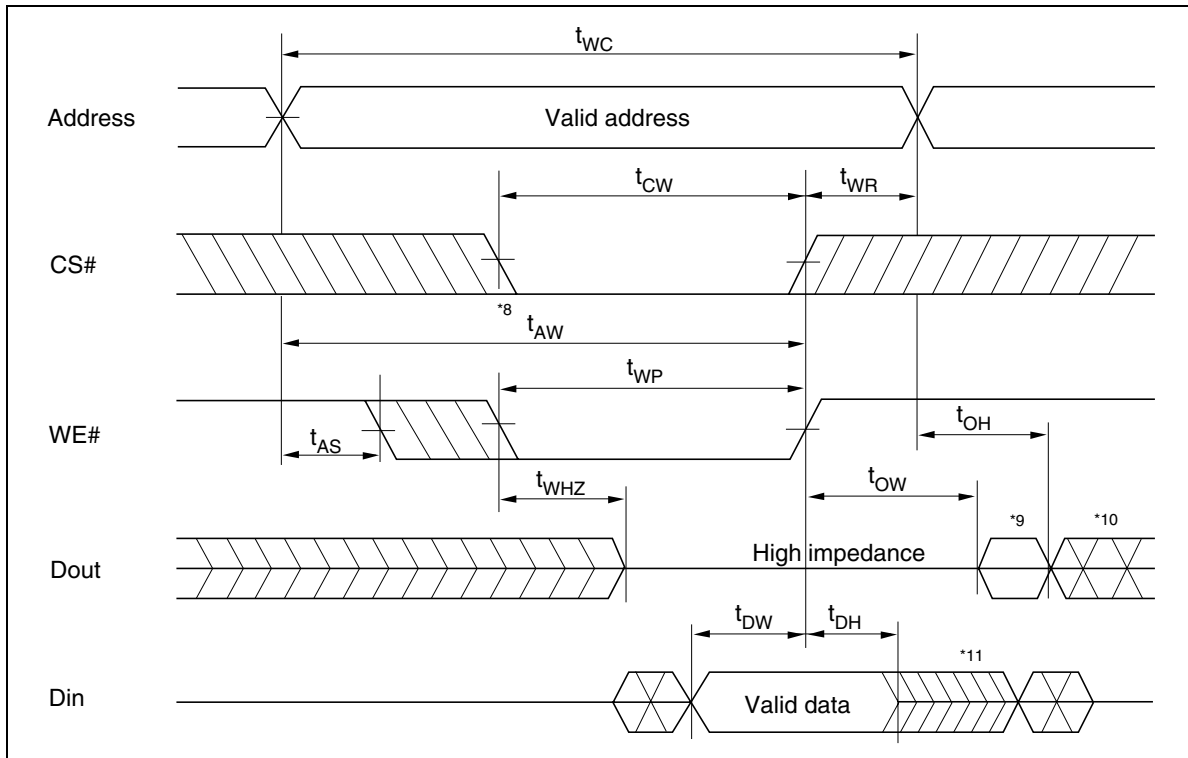
### Read Timing Waveform (WE# = V<sub>ih</sub>)



Write Timing Waveform (1) (OE# Clock)



Write Timing Waveform (2) (OE# Low Fixed)



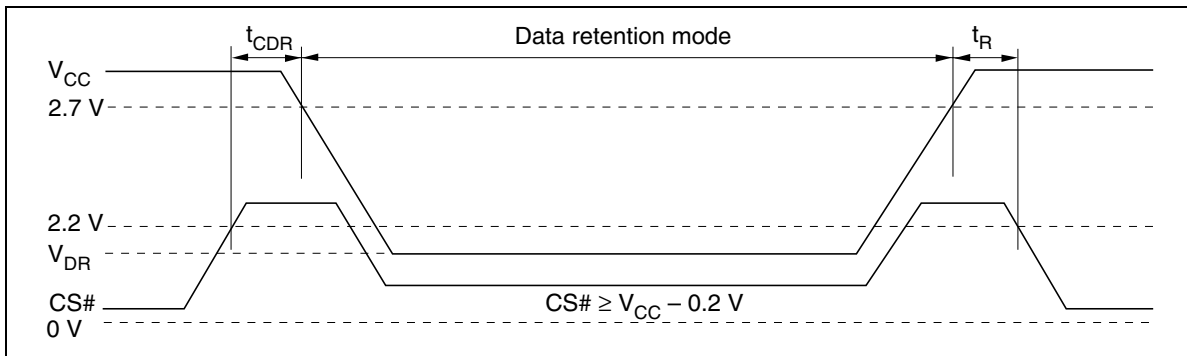
### Low V<sub>CC</sub> Data Retention Characteristics

(T<sub>a</sub> = 0 to +70°C / -40 to +85°C)

| Parameter                            |      | Symbol           | Min               | Typ | Max | Unit | Test conditions                          |   |
|--------------------------------------|------|------------------|-------------------|-----|-----|------|--|---|
| V <sub>CC</sub> for data retention   |      | V <sub>DR</sub>  | 2                 | —   | —   | V    | CS# ≥ V <sub>CC</sub> - 0.2 V, Vin ≥ 0 V |   |
| Data retention current               | -5S% | to +85°C         | I <sub>CCDR</sub> | —   | —   | 10   | μA                                       | V <sub>CC</sub> = 3.0 V, Vin ≥ 0 V<br>CS# ≥ V <sub>CC</sub> - 0.2 V<br>Average values |
|                                      |      | to +70°C         | I <sub>CCDR</sub> | —   | —   | 8    | μA                                       |   |
|                                      |      | to +40°C         | I <sub>CCDR</sub> | —   | —   | 3    | μA                                       |   |
|                                      |      | to +25°C         | I <sub>CCDR</sub> | —   | 1*1 | 2.5  | μA                                       |   |
|                                      | -7L% | to +85°C         | I <sub>CCDR</sub> | —   | —   | 20   | μA                                       |   |
|                                      |      | to +70°C         | I <sub>CCDR</sub> | —   | —   | 16   | μA                                       |   |
|                                      |      | to +40°C         | I <sub>CCDR</sub> | —   | —   | 10   | μA                                       |   |
|                                      |      | to +25°C         | I <sub>CCDR</sub> | —   | 1*1 | 10   | μA                                       |   |
| Chip deselect to data retention time |      | t <sub>CDR</sub> | 0                 | —   | —   | ns   | See retention waveform                   |   |
| Operation recovery time              |      | t <sub>R</sub>   | 5                 | —   | —   | ms   |  |   |

Note: 1. Typical values are at V<sub>CC</sub> = 3.0 V, T<sub>a</sub> = +25°C and specified loading, and not guaranteed.

### Low V<sub>CC</sub> Data Retention Timing Waveform (CS# Controlled)



**Revision History****R1LV0408D Series Data Sheet**

| Rev. | Date          | Contents of Modification |   |
|------|---------------|--------------------------|---|
|      |               | Page                     | Description   |
| 0.01 | Dec. 25, 2006 | —                        | Initial issue   |
| 1.00 | May. 24, 2007 | 6                        | DC Characteristics<br>$I_{SB1}$ (-5S%) (to +25°C) max: 3 $\mu$ A to 2.5 $\mu$ A   |
|      |               | 12                       | Low $V_{CC}$ Data Retention Characteristics<br>$I_{CCDR}$ (-5S%) (to +25°C) max: 3 $\mu$ A to 2.5 $\mu$ A<br>Deletion of note 2 |

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